

1340 x 400 imaging array | 20 x 20 μm pixels



The Princeton Instruments PIXIS-XO: 400B is a fully integrated, innovative imaging system that utilizes a CCD without AR coating for very low energy X-ray detection. With 1340 x 400, 20 μm pixels, 100% fill factor, deep thermoelectric cooling with air or water and low noise electronics this system is ideal for worry-free operation in research and OEM environments. The Conflat flange with high-vacuum-seal design, software-selectable gains and readout speeds make the camera well suited for ultra-high vacuum applications.

**Applications:** X-ray spectroscopy, EUV lithography, X-ray plasma diagnostics

Features	Benefits	
Back-illuminated CCD, no AR coating, direct detection technology	Provides very low X-ray flux imaging, high sensitivity and high spatial resolution	
2 Mhz / 16-bit readout 100 kHz / 16-bit readout	High speed readout for rapid image acquisition Slow speed readout for high sensitivity with wide dynamic range, high signal-to-noise ratio (SNR) and excellent energy resolution	
Software selectable gains for each digitization speed	Allows optimization of system performance for lowest noise to highest SNR	
1340 x 400 image area, 20 x 20 μm pixels	Spectroscopy format designed for high-frame-rate imaging	
Ultra low noise electronics	Best possible system performance	
Flexible user selectable binning and readout	Total flexibility to optimize experiments and SNR	
Deep thermoelectric cooling	Air	Water
	Maintenance-free operation without the need for a liquid circulator or an additional power supply	Vibration free operation
Conflat vacuum interface	Industry-standard, high-vacuum compatibility	
TTL input and output	External Trigger input with programmable polarity TTL output with exposure or readout monitor	
“USB 2.0 interface” configuration	Seamless, plug-and-play connection to PC notebooks and desktops Easy OEM integration	
WinView and PVCAM®	Offers powerful, easy-to-use set of Windows® GUI controls Automates data acquisition, analysis, and display	
Linux® drivers and SITK™ plug-in for National Instruments' LabVIEW™	Extends system utility	

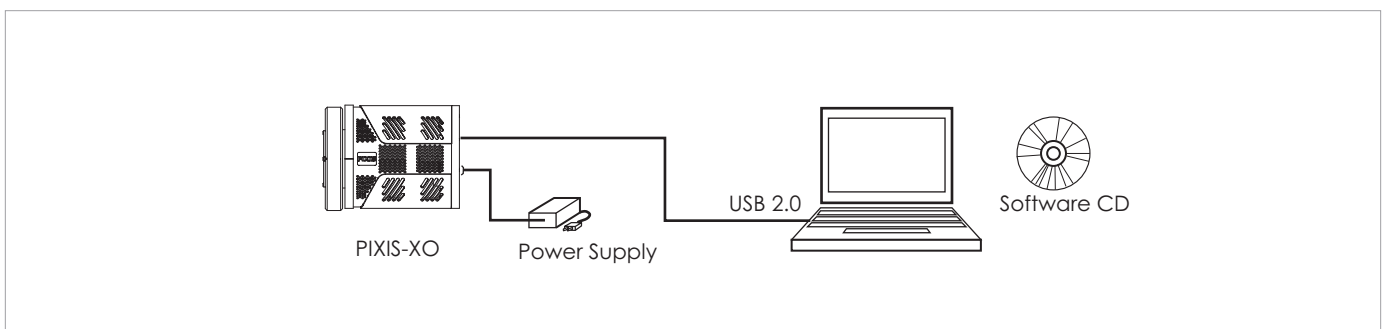
## PIXIS-XO: 400B Specifications

<b>CCD image sensor</b>	Princeton Instruments exclusive; scientific grade 1; MPP; back-illuminated device; without AR coating					
<b>CCD format</b>	1340 x 400 imaging pixels 20 x 20 $\mu\text{m}$ pixels 100% fill factor 26.8 x 8.0 mm imaging area (optically centered)					
	Minimum		Typical		Maximum	
	High Sensitivity	High Capacity	High Sensitivity	High Capacity	High Sensitivity	High Capacity
<b>System read noise</b> @ 100 kHz digitization @ 2 MHz digitization			3.5 e- rms 13 e- rms	10 e- 25 e-	5 e- rms 16 e- rms	12 e- 30 e-
<b>Spectrometric well capacity</b>	250 ke-	800 ke-	300 ke-	300 Me-		
<b>Dark current @ -75°C operation</b>	0.005 e-/p/s			0.01 e-/p/s		
<b>Cooling Method</b>	Thermoelectric Air (standard); Water cooled (optional)					
<b>Deepest cooling temperature</b>	-70°C		-75°C			
<b>Thermostating precision</b>	$\pm 0.05^\circ\text{C}$ across entire temperature range					
<b>Software-selectable gains</b> (e-/count)	1, 2, 4 (high sensitivity mode) 4, 8, 16 (high capacity mode)					
<b>Operating system support</b>	Windows 2000/XP; Linux					
<b>Data interface</b>	USB2.0 (5m interface cable provided) Optional Fiberoptic interface is available for remote operation					
<b>I/O signals</b>	Two MCX connectors for programmable frame readout, shutter trigger in					
<b>Certification</b>	CE					
<b>Dynamic range</b>	16 bits					
<b>Nonlinearity</b>	< 1% @ 100 kHz, < 2% @ 2 MHz					
<b>Vertical shift rate</b>	30 $\mu\text{sec}$ per row					
<b>Spectral rates*</b> @ 100 kHz digitization @ 2 MHz digitization	41 spectra/sec (FVB) 74 spectra/sec (FVB); 1000 spectra/sec (0.5 mm high)					
<b>Operating environment</b>	+5 to +30°C non-condensing					
<b>Bakeout temp.</b>	70°C (max)					
<b>Vacuum compatibility</b>	$10^{-8}$ Torr.					

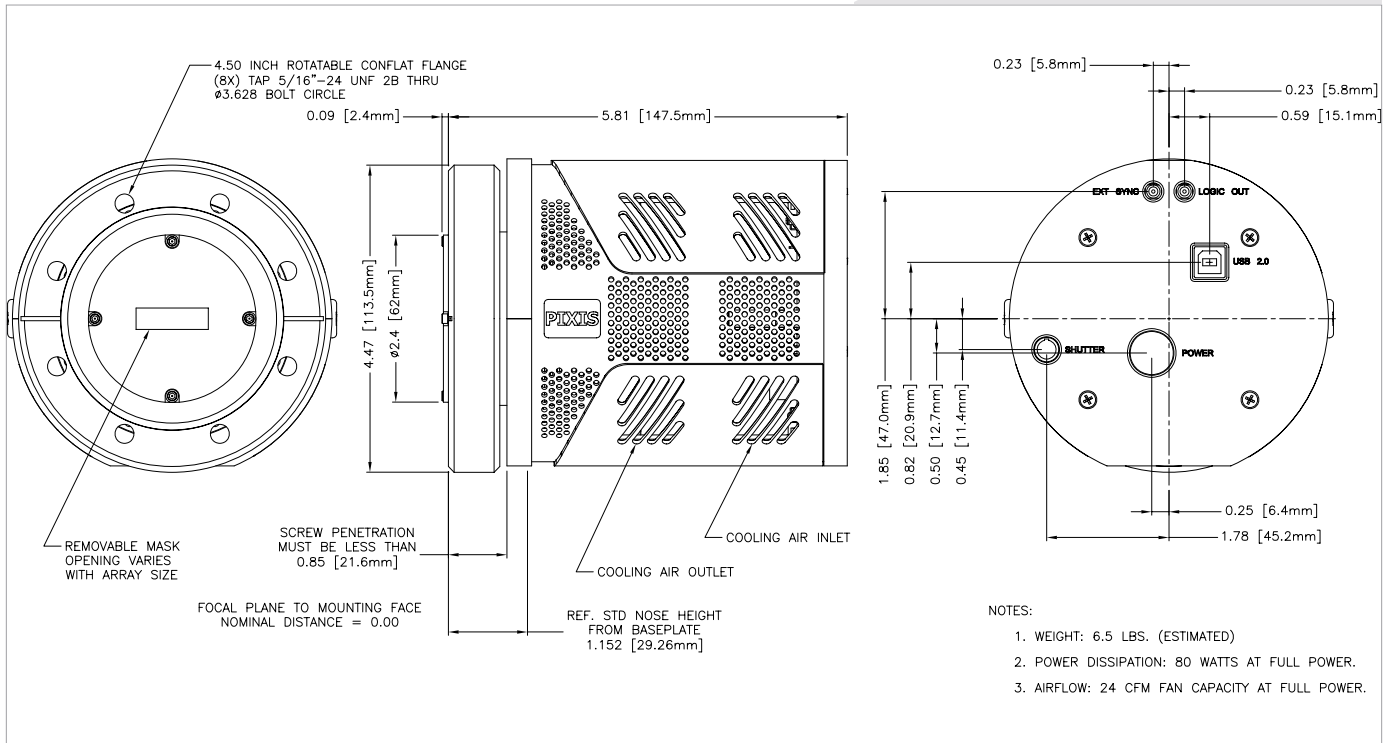
Notes: All specifications subject to change.

\* Spectral rates measured with all rows vertically binned.

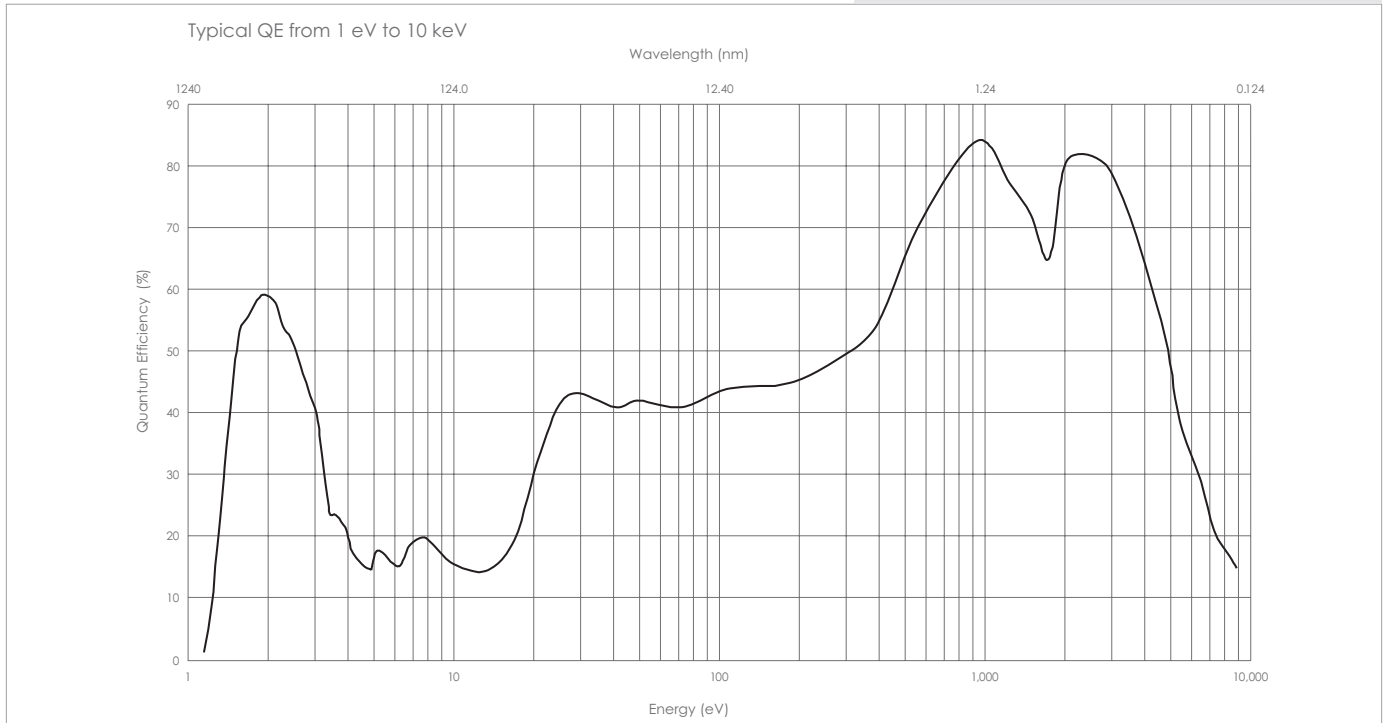
\* The minimum temperature attainable is dependent on the vacuum condition (can be lowered with lower vacuum).



PIXIS-XO Drawing



Quantum Efficiency Curve



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